

## **DETAILED ACTION**

### **Response to Amendment**

1. This Office Action is in response to Amendment filed on date: 04/24/2008.

Claims 33-36, 41-49, 54-57, 59-68, 70 and 71 are still pending.

### **Reasons for Allowance**

2. Claims 33-36, 41-49, 54-57, 59-68, 70 and 71 are allowed.

The following is a statement of reason for the indication of allowance:

Independent claim 63 contains limitations from cancelled dependent claim 69, which was indicated as allowable subject matter in the previous Office Action mailed 01/25/2008.

Claims 64-68, 70 and 71 are allowed as being dependent on independent claim 63.

Claims 33-36, 41-49, 54-57 and 59-62 were allowed in the previous Office Action mailed 01/25/2008.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

***Conclusion***

3. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Huy Q Phan whose telephone number is 571-272-7924. The examiner can normally be reached on 8AM-6PM.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Duc Nguyen can be reached on 571-272-7503. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see <http://pair-direct.uspto.gov>. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

/Huy Q Phan/

Examiner, Art Unit 2617

Date: 06/03/2008

/Duc Nguyen/

Supervisory Patent Examiner, Art Unit 2617